


<b>Search Notes</b>  	<b>Application/Control No.</b>  10527087	<b>Applicant(s)/Patent Under Reexamination</b>  MAEKAWA ET AL.
	<b>Examiner</b>  Brian Szmaj	<b>Art Unit</b>  3736

SEARCHED			
Class	Subclass	Date	Examiner
600	546, 511, 300	3/19/08	BS
607	45	3/19/08	BS

SEARCH NOTES		
Search Notes	Date	Examiner
WEST: updated search	3/19/08	BS
STIC search	2/28/08	BS
PLUS search	3/19/08	BS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
As	Above	3/19/08	BS